Se	earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/660,055	KNEE ET AL.	
Examiner	Art Unit	
Sargon N. Nano	2157	

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Class	Subclass	Date	Examiner
709	223, 225 230	2/13/2007	SN
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (see attached report)	2/13/2007	SN
Consulted with Todd Swan for 101 issues	2/13/2007	SN
Consulted with Pat Salce for double patenting	2/13/2007	SN
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